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Design and Simulation of Efficient SnS-Based Solar Cell Using Spiro-OMeTAD as Hole Transport Layer

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Abstract: In the present paper, the theoretical investigation of the device structure ITO/CeO₂/SnS/Spiro-OMeTAD/Mo of SnS-based solar cell has been performed. The aim of this work is to examine how the Spiro-OMeTAD HTL affects the performance of SnS-based heterostructure solar cell. Using SCAPS-1D simulation software, various parameters of SnS-based solar cell such as work function, series and shunt resistance and working temperature have been investigated. With the help of Spiro-OMeTAD, the suggested cell's open-circuit voltage was increased to 344 mV. The use of Spiro-OMeTAD HTL in the SnS-based solar cell resulted in 14% efficiency increase, and the proposed heterojunction solar cell has 25.65% efficiency. The cell's performance is determined by the carrier density and width of the CeO₂ ETL (electron transport layer), SnS absorber layer and Spiro-OMeTAD HTL (hole transport layer). These data reveal that the Spiro-OMeTAD solar cells could have been a good HTL (hole transport layer) in regards to producing SnS-based heterojunction solar cell with high efficiency and reduced cost.

Keywords: Spiro-OMeTAD; SnS; CeO₂; heterojunction solar cell; HTL (hole transport layer)

1. Introduction

Thin-film solar cells are a popular field in the scientific world. The solar cell economy is rapidly changing and progressing; economically viable thin-film solar cells is a new problem. Production of material cost competitiveness in thin-film solar cells is no longer possible when compared to wafer-based technologies, and new technologies are required to enhance efficiency and reduce cost. Taking this into account, SnS (orthorhombic tin monosulphide) has become an important absorbent layer of thin-film solar cells [1–8]. SnS offer several benefits, including an energy band gap of 1.31 eV and a larger absorption coefficient of 10⁵ cm⁻¹, allowing SnS layers to absorb a large portion of the solar spectrum [9]. Furthermore, SnS-based solar cell is a non-toxic and abundant material that may be produced at a minimal price using dip coating, spin coating and spray pyrolysis

methods [10–14]. A number of functional SnS-based heterojunction solar cells have been described in recent years [15–17]. At present, the ZnS/SnS heterostructure has maximum efficiency of 16.26% [18]. To fabricate a device, having high efficiency at low cost, CeO₂ as an ETL is an appropriate choice for SnS-based solar cells because of the large tunable bandgap (3.0–3.6 eV) and superior electrical and optical properties [19,20]. A simple, low-cost sol-gel dip coating and spin coating process can be used to synthesize CeO₂ [21]. According to Tan et al., nanostructured CeO₂/Al back electrode could improve the light trapping of the solar cells [19].

Further, in this study Spiro-OMeTAD is used as HTL (hole transport layer) material due to its ease of fabrication and high performance [22–24]. It possesses a high glass transition temperature (T_g), so it is simple to deal with, having stable morphology while maintaining all electrical properties. The post-annealing treatment is not required for Spiro-OMeTAD and it has large solubility as well. For SnS-based solar cell, Spiro-OMeTAD is a good HTL because of its good band alignment with SnS.

Numerical simulation of a photovoltaic device would be required to determine the optimum parameters of a model and assess the effect of physical parameters on model performance. The simulation method is validated by comparing simulation results to experimental data. Herein, the device is simulated by SCAPS-1D program, and the influence of various structural properties of SnS layer, CeO₂ layer and Spiro-OMeTAD layer on the performance of SnS-based solar cell has been thoroughly examined. The modelling and advancement of a unique device structure (ITO/CeO₂/SnS/Spiro-OMeTAD/Mo) of an SnS-based solar cell using the CeO₂ electron transport layer and Spiro-OMeTAD HTL have been proposed.

The goal of this research is to demonstrate that the efficiency of a solar cell can be enhanced by trapping incident light on its surface and optimizing the various parameters of the device structure.

2. Structure and Material Properties of Solar Cell

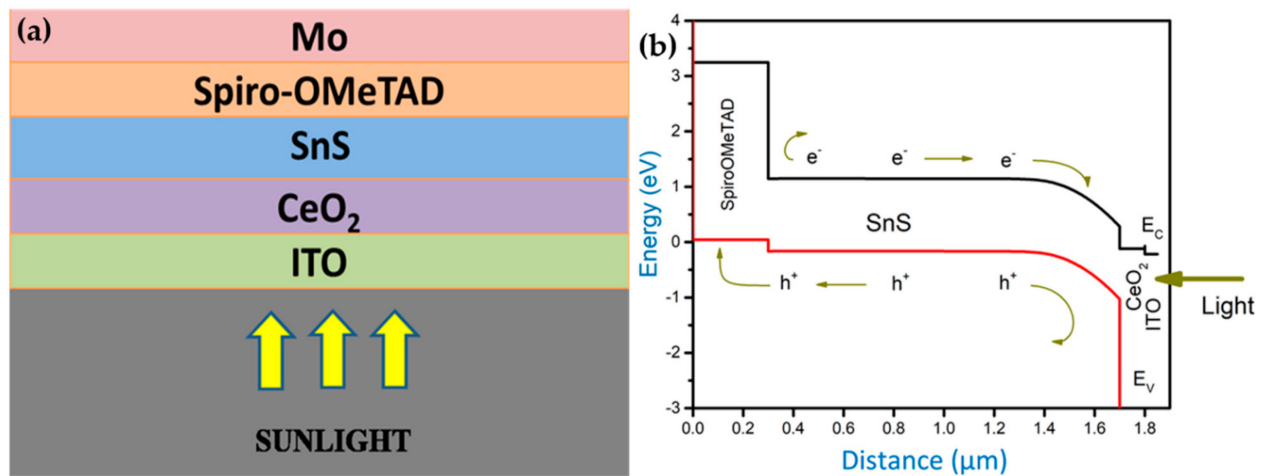
The suggested ITO/CeO₂/SnS/Spiro-OMeTAD/Mo solar cell schematic structure is shown in Figure 1a. ITO serves as a front contact TCO, CeO₂ works as the window layer, Spiro-OMeTAD operates as the HTL, SnS acts as the absorber layer and Mo serves as the rear contact. The suggested structure's energy band diagram (Figure 1b) reveals that the conduction band of the absorber layer SnS is less than that of the CeO₂ ETL layer, and the conduction band offset (CBO) between SnS and CeO₂ layer is very small. As a result, electrons can flow from SnS to ITO easily through CeO₂. So, the electrons can flexibly move through CeO₂ from SnS to ITO. In between the absorber layer SnS and the ETL layer CeO₂, there is a valance band offset (VBO) which is extremely high. As a result, the holes at ETL layer CeO₂ will be blocked. The valance band of Spiro-OMeTAD HTL is higher than that of absorber layer SnS as shown in Figure 1b, and the valance band offset between these two layers is substantially smaller. In addition, the CBO between HTL layer Spiro-OMeTAD and absorber layer SnS is quite large, preventing electrons from SnS from reaching the back electrode. Table 1 lists the physical parameters for the simulations of ITO/CeO₂/SnS/Spiro-OMeTAD/Mo heterostructure solar cell [20], whereas Table 2 lists the physical parameters of defect density present in SnS.

Table 1. Physical parameters of ITO/CeO₂/SnS/Spiro-OMeTAD/Mo heterostructure solar cell.

Parameters	ITO	CeO ₂	SnS	Spiro-OMeTAD
Thickness (nm)	50	100	1400	100
Band gap (eV)	3.6	3.5	1.31	3.2
Electron affinity (eV)	4.5	4.6	4.2	2.1
Dielectric permittivity (relative)	8.9	9	13	3

Table 1. Cont.

Parameters	ITO	CeO ₂	SnS	Spiro-OMeTAD
CB effective density of states (cm ⁻³)	2.2×10^{18}	1×10^{20}	1.18×10^{18}	2.5×10^{18}
VB effective density of states (cm ⁻³)	1.8×10^{18}	2×10^{21}	4.76×10^{18}	1.8×10^{19}
Electron mobility (cm ² /Vs)	10	100	130	2×10^4
Hole mobility (cm ² /Vs)	10	25	4.3	2×10^4
Shallow uniform donor density N _d (cm ⁻³)	1×10^{21}	1×10^{21}	0	0
Shallow uniform acceptor density N _a (cm ⁻³)	0	0	10^{15}	1×10^{20}
Electron thermal velocity (cm/s)	1×10^7	1×10^7	1×10^7	1×10^7
Hole thermal velocity (cm/s)	1×10^7	1×10^7	1×10^7	1×10^7
Defect density (cm ⁻³)	0	1×10^{14}	1×10^{14}	
Radiative recombination coefficient (cm ³ /s)	0	2.3×10^{-9}	2.3×10^{-9}	2.3×10^{-9}

**Figure 1.** (a) Schematic layout of the proposed heterostructure solar cell and (b) the energy band diagram of the proposed heterostructure solar cell.**Table 2.** Interface values are employed in the device simulation.

Parameters	Spiro-OMeTAD/SnS Interface	CeO ₂ /SnS Interface
Defect type	Neutral	Neutral
Capture cross-section electrons (cm ²)	1×10^{-19}	1×10^{-19}
Capture cross-section holes (cm ²)	1×10^{-19}	1×10^{-19}
Defect energy level E _t	Above the highest E _v	Above the highest E _v
Energy with respect to a reference (eV)	0.06	0.06
Total density (cm ⁻²)	1×10^{10}	1×10^{10}

3. Results and Discussion

3.1. CeO₂/SnS Solar Cell Open-Circuit Voltage

In solar cell, V_{OC} (open-circuit voltage) is determined by the dark current density. For thin-film solar cell, it can be computed as:

$$J_0 = qn_i^2 S / N_D \quad (1)$$

where q denotes the charge, N_D denotes ETL doped concentration, S denotes radiative recombination rate at the absorber/electrode interface and n_i denotes absorber material's inherent carrier density. Hence, the dark current at the absorber/electrode contact is proportional to the surface recombination rate. As an outcome, the metallization of the absorber surface is crucial for improving both V_{OC} and the performance of the cell. Figure 2a,b display the J-V curve and QE curve with and without Spiro-OMeTAD, respectively. The cell without Spiro-OMeTAD has V_{OC} of 0.8421 V, FF of 80.98%, J_{sc} of 31.83 mA/cm² and PCE of 21.71% and with Spiro-OMeTAD V_{OC} is 0.8878 V, FF is 85.61%, J_{sc} is 33.74 mA/cm² and PCE is 25.65%. As a result, the Spiro-OMeTAD HTL enhances the (V_{OC}) voltage level as well as the PCE of the proposed solar cell. Due to excessive band offset, the Spiro-OMeTAD HTL appropriate band alignment will extend high potential, increasing the V_{OC} . Figure 2b illustrates the Spiro-OMeTAD HTL, magnifying the quantum efficiency of the solar cell.

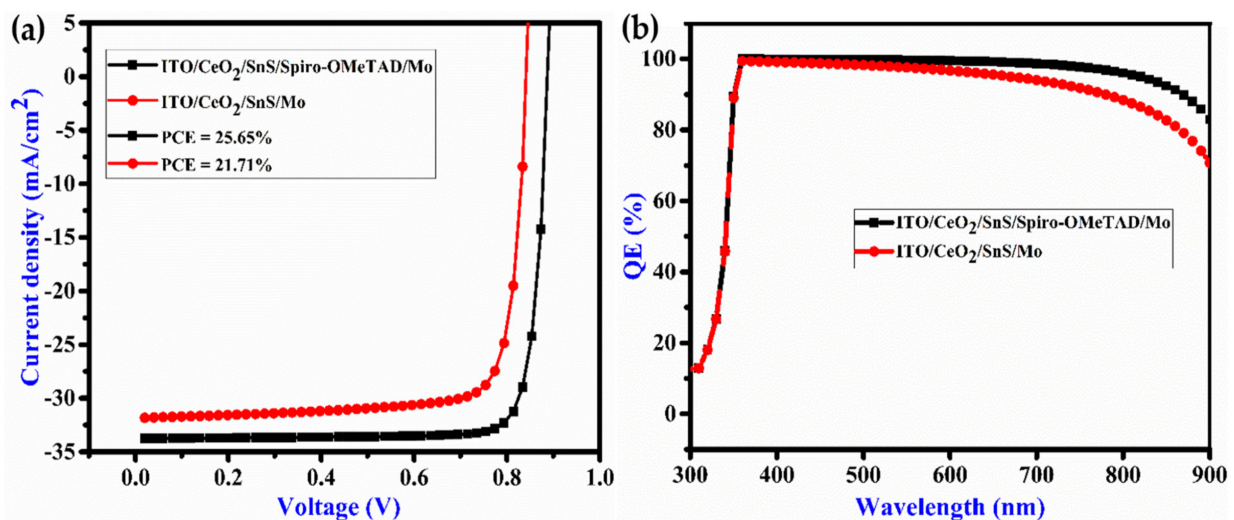


Figure 2. (a) J-V curve and (b) quantum efficiency of a proposed solar cell.

3.2. Effect of Spiro-OMeTAD/SnS Layers Interface on Defect Density

The role of the Spiro-OMeTAD/SnS interface on the performance of the solar cell was analyzed. The defect density varied from 10^{10} to 10^{18} cm⁻², and the findings demonstrate that the density of interface defect of Spiro-OMeTAD/SnS has no impact on the performance of the solar cell till 10^{16} cm⁻². With a further increase in the defect density above 10^{16} cm⁻², the performance of the solar cell reduces marginally which can be solved by increasing the thickness of SnS layer.

3.3. Interface Defect Density of CeO₂/SnS Layers

The probability of defect at CeO₂/SnS interface varied from 10^{10} to 10^{18} cm⁻². This defect increases the recombination rate due to which a decrease in V_{OC} is observed. Series resistance also increases due to which fill factor decreases. As a result, the high CeO₂/SnS defect is to blame for higher series resistance. This reveals that the density of CeO₂/SnS defects has a huge influence on solar cell performance. The structural imperfections of the two materials as well as metal cation passage through the absorbent layer during cell manufacturing cause interfacial defects [18].

3.4. Working Temperature and Back Contact Metal Work Function

The effect of WF (work function) on the performance of the cell is evaluated as shown in Figure 3a–d. As the WF rises, V_{OC} , FF and PCE also increase, up to a particular value of WF. This specifies that with higher WF, the majority of carrier barrier height decreases. As a result, WF has a profound impact on the performance of the solar cell. To achieve high efficiency, a suitable metal contact is required.

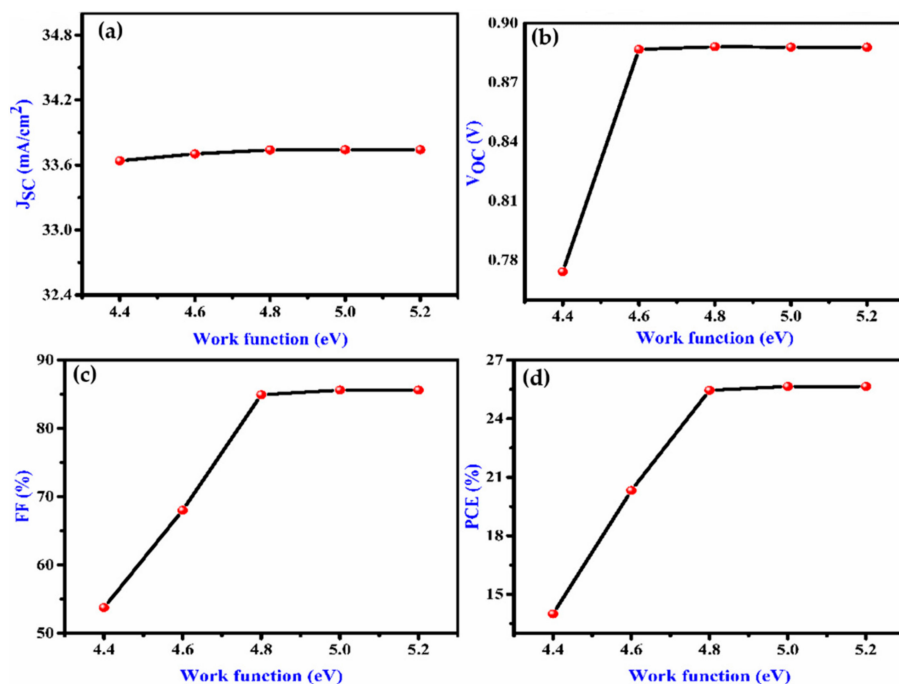


Figure 3. Effect on (a) J_{SC} , (b) V_{OC} (c) FF (d) and PCE with variation of work function (eV) of the proposed device.

If we increase the temperature of a semiconductor device, the velocity of the charge carrier increases and the band energy decreases. The reduction in band energy results in the reduction of the bandgap. At high temperatures, there will be a loss of power. As shown in Figure 4a–d, J_{SC} is unaffected by working temperature, whereas V_{OC} decreases as working temperature rises. Therefore, increasing working temperature lowers the solar cell efficiency.

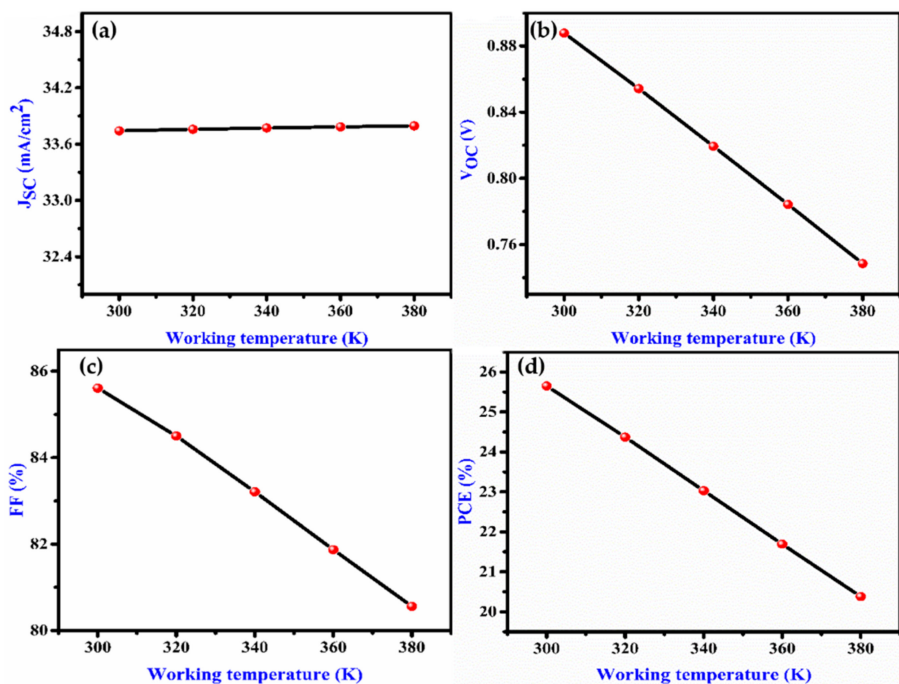


Figure 4. Effect on (a) J_{SC} , (b) V_{OC} , (c) FF and (d) PCE with variation of temperature of the proposed device.

3.5. Series Resistance and Shunt Resistance

The R_s and R_{sh} have a great influence on the performance of solar cells. It rises from the metal contacts of layers and solar cell. The functioning of the device was evaluated by altering the resistance from 2 to 25 $\Omega\text{-cm}^2$. Figure 5a–d illustrates that the V_{OC} and J_{SC} are unaffected by R_s ; however, the FF and PCE drop as R_s is increasing causes power dissipation.

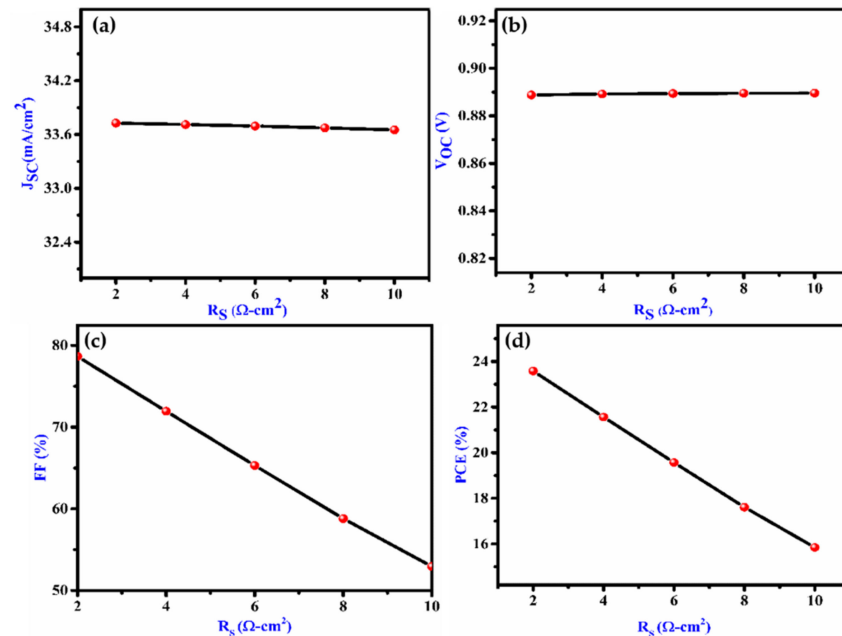


Figure 5. Effect on (a) J_{SC} , (b) V_{OC} , (c) FF and (d) PCE with variation of series resistance of the proposed device.

Manufacturing flaws are the cause of R_{sh} . The shunt resistance was altered from 100 to 1000 cm^2 . V_{OC} reduces when R_{sh} lowers because of the reduction of current to R_{sh} . As seen in Figure 6a–d, $R_{sh} > 600 \Omega\text{ cm}^2$ has very little effect on PCE. As a result, low shunt resistance has a huge impact on the performance of the cell.

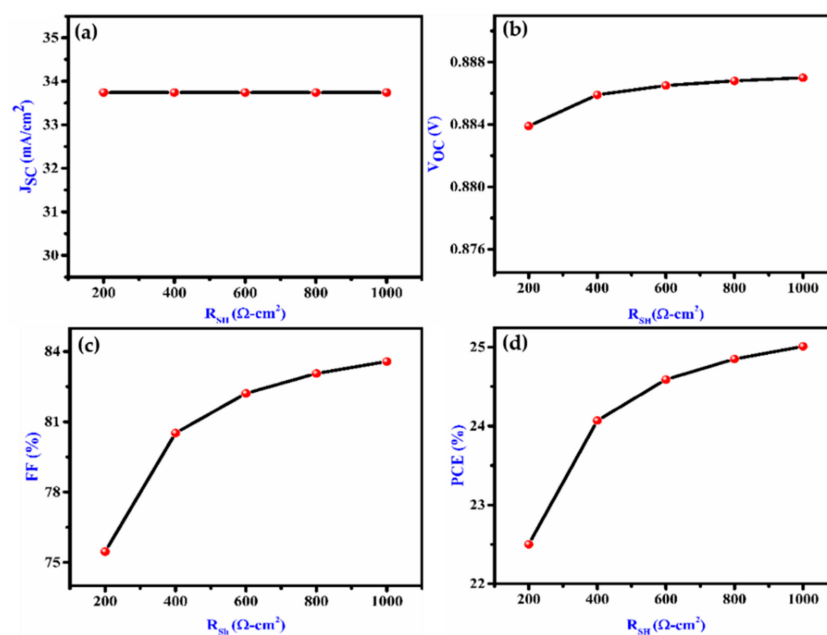


Figure 6. Effect on (a) J_{SC} , (b) V_{OC} , (c) FF and (d) PCE with variation of shunt resistance of the proposed device.

3.6. Layer Thicknesses and Carrier Concentration of SnS, CeO₂ and Spiro-OMeTAD Layer Optimization

The performance of the cell was evaluated in terms of layer thickness and carrier concentration. Fill factor and efficiency of 85.61% and 25.65% are established at Spiro-OMeTAD and CeO₂ thicknesses as well as carrier concentration of 100 nm and 10⁻²¹ cm⁻³ accordingly.

The reduction of photogenerated charge carrier recombination is indicated by V_{OC} increasing slightly with Spiro-OMeTAD carrier concentration. At Spiro-OMeTAD thickness and carrier concentration of >100 nm and 10¹⁶ cm⁻³, FF and PCE were found to decrease with thickness but were unaffected by carrier concentration. Whereas, at Spiro-OMeTAD carrier concentration > 10¹⁶ cm⁻³, FF and PCE increase with carrier concentration but are unaffected by thickness.

In cases of CeO₂-when the thickness increases, V_{OC} drops but increases as the carrier concentration rises. By CeO₂ thickness, FF is unaffected, although it rises in proportion to concentration of CeO₂.

The primary influential criteria in designing solar cells are carrier concentration and absorber layer thickness. To achieve maximal device efficiency, both the functions must be maintained. To test the working of the cell, the concentration and thickness are tuned from 10¹¹ to 10²¹ cm⁻³ and 200 to 2000 nm, respectively. At SnS thickness of 1400 nm and carrier concentration of 10¹⁶ cm⁻³, maximum PCE of 25.65% was recorded.

Table 3 shows a comparison of experimental and simulation results. Our results appear to be in satisfactory correlation with those previously reported. The distinctions between simulations and experiments are important to their methodology. There is a significant difference between experimental and simulation results because experiments are performed directly on the target machine, whereas software simulations are never performed in this manner. The experiments give confirmation of the object's true behavior, with variable measurement errors, while simulated results provide insights based on similar theoretical models. As a result, the distinction is mostly between the real object and its theoretical and numerical descriptions, especially when other errors are greatly minimized.

Table 3. Comparison of physical parameters of various simulated and experimentally studied device structures.

Structures	V _{OC} V	J _{SC} mA/cm ²	FF %	PCE %	References
SnS/Zn(O,S) (experimentally)	0.244	19.42	42.97	2.04	[19]
SnS/SnO ₂ /Zn(O,S):N/ZnO (experimentally)	0.372	20.20	58.00	4.36	[4]
CZTS/SnS ₂ /ZnO (simulated)	0.7178	26.99	65.67	12.73	[25]
Mo/SnS/CZTS/SnS ₂ /ZnO (simulated)	0.9922	20.13	71.33	14.24	[26]
ZnO/CdS/CdTe/SnS/Ni (simulated)	0.845	26.46	84.50	21.83	[27]
p-SnS/CdS/n-Zn MgO (simulated)	~0.7	38.54	83	~23	[28]
ITO/CeO ₂ /SnS/NiO/Mo (simulated)	0.890	32.67	86.19	25.06	[29]
ITO/CeO ₂ /SnS/Spiro-OMeTAD (simulated)	0.887	33.74	85.61	25.65	This paper

4. Conclusions

Using the SCAPS-1D simulator, the performance of the proposed cell structure ITO/CeO₂/SnS/Spiro-OMeTAD/Mo has been analyzed. To investigate the cell performance, distinct parameters of CeO₂, Spiro-OMeTAD and SnS are optimized. The Spiro-OMeTAD made a considerable donation to the open-circuit voltage and efficiency. The higher carrier concentration of the CeO₂ ETL was found to be beneficial to cell performance. The thickness of SnS appears to be a key component in determining cell performance. Due to their large impact on the resistance in series, CeO₂/SnS density of interface defect and SnS defect density were optimized. The maximum recorded PCE with Spiro-OMeTAD HTL is 25.65% with J_{SC} of 33.74% mA/cm², V_{OC} of 0.887 V and fill factor of 85.61%. Our result shows that

SnS-based proposed device structure could prove to be an efficient device for low-cost and highly efficient thin-film solar cell in future work.

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